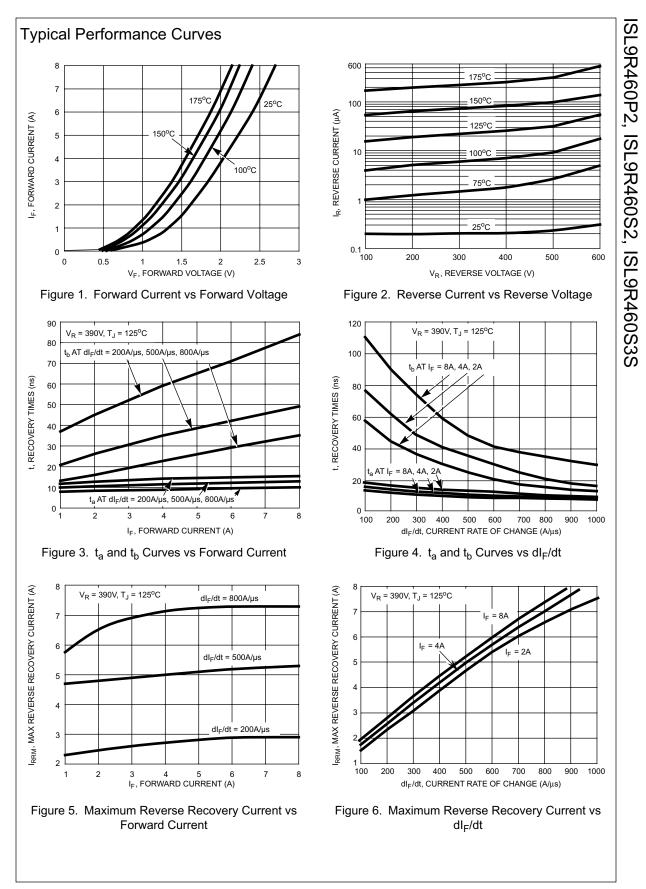
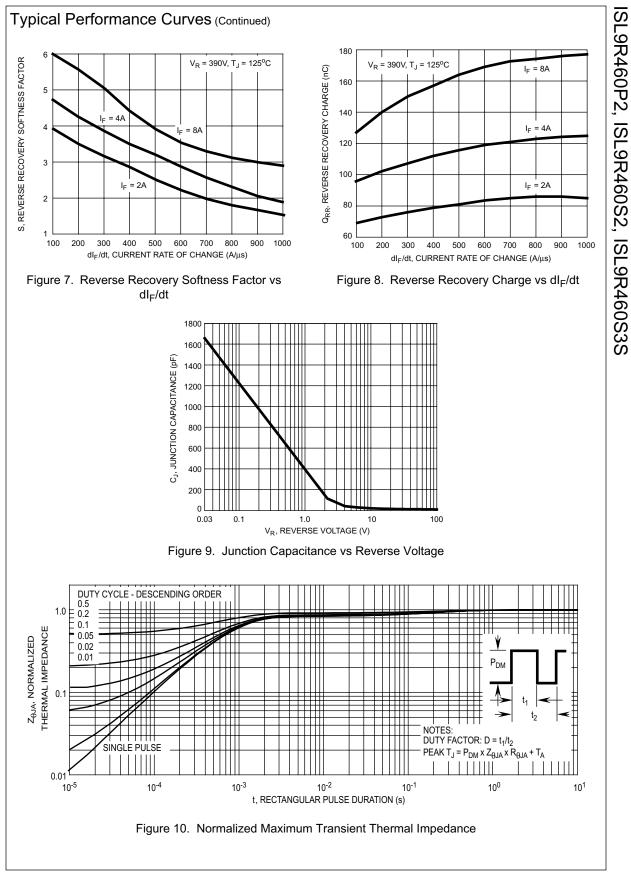
	CHILD		Janu	ary 2002	
ISL9R4	60P2, ISL9R460S2, IS	L9R460S3S			
4A, 600V	Stealth™ Diode				
General Description The ISL9R460P2, ISL9R460S2 and ISL9R460S3S are Stealth™ diodes optimized for low loss performance in high frequency hard switched applications. The Stealth™ family exhibits low reverse recovery current (I _{RRM}) and exceptionally soft recovery under typical operating conditions. This device is intended for use as a free wheeling or boost diode in power supplies and other power switching applications. The low I _{RRM} and short t _a phase reduce loss in switching transistors. The soft recovery minimizes ringing, expanding the range of conditions under which the diode may be operated without the use of additional snubber circuitry. Consider using the Stealth™ diode with an SMPS IGBT to provide the most efficient and highest power density design at lower cost. Formerly developmental type TA49408.		Features• Soft Recovery. $t_b / t_a > 3$ • Fast Recovery . $t_{rr} < 20ns$ • Operating Temperature . $175^{\circ}C$ • Reverse Voltage. $600V$ • Avalanche Energy RatedApplications• Switch Mode Power Supplies• Hard Switched PFC Boost Diode• UPS Free Wheeling Diode• Motor Drive FWD• SMPS FWD• Snubber Diode			
Package			S	ymbol	
JE CATHODE (FLANGE)	ANODE CATHODE (FLANGE)	E TO-262 JEDEC TO NODE CATHODE N/C ANODE	CATHODE (FLANGE)	к А	
Device M	aximum Ratings T _C = 25°C unless oth	erwise noted			
Symbol	Parameter		Ratings	Units	
V _{RRM}	Peak Repetitive Reverse Voltage 600 V				
V _{RWM}	Working Peak Reverse Voltage 600 V				
V _R	DC Blocking Voltage 600 V			V	
I _{F(AV)}	Average Rectified Forward Current 4 A			A	
I _{FRM}	Repetitive Peak Surge Current (20kHz Squa	re Wave)	8	A	
I _{FSM}	Nonrepetitive Peak Surge Current (Halfwave	e 1 Phase 60Hz)	50	A	
P _D	Power Dissipation	•	58	W	
E _{AVL}	Avalanche Energy (1A, 20mH)		10	mJ	
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to 175	°C	
T _L T _{PKG}	Operating and Storage Temperature Range -55 to 175 C Maximum Temperature for Soldering			°C °C rating and	

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V _{RRM}	Peak Repetitive Reverse Voltage	600	V	
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I _{F(AV)}	Average Rectified Forward Current	4	A	
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PD	Power Dissipation	58	W	
E _{AVL}	Avalanche Energy (1A, 20mH)	10	mJ	
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to 175	°C	
TL	Maximum Temperature for Soldering			
T _{PKG}	Leads at 0.063in (1.6mm) from Case for 10s	300	°C	
	Package Body for 10s, See Techbrief TB334	260	°C	

	Marking	Device	Package	Tape Width	<u> </u>		Quan	tity
R46	60P2	ISL9R460P2	TO-220AC	-			-	
R46	60S2	ISL9R460S2	TO-262	-			-	
R46	0S3S	ISL9R460S3S	TO-263AB	-			-	
R46	0S3S	ISL9R460S3ST	TO-263AB	24mm			800)
lectric	al Chara	cteristics $T_{C} = 25^{\circ}C$ unless	ss otherwise note	d			·	
Symbol		Parameter	Test C	onditions	Min	Тур	Max	Units
ff State	Character	istics						
I _R I	Instantaneo	Instantaneous Reverse Current		$V_{R} = 600V$ $T_{C} = 25^{\circ}C$	-	-	100	μA
ix.				T _C = 125°C	-	-	1.0	mA
n Stata	Character	ristics			1			
V _F		bus Forward Voltage	I _F = 4A	T _C = 25°C	-	2.0	2.4	V
· r				$T_{\rm C} = 125^{\circ}{\rm C}$	-	1.6	2.0	V
	Chara-t	iation			1	-		!
•	Character		V _R = 10V, I _F = 0A			10	1	~ [
CJ	Junction Ca	apacitance	$ V_{\rm R} = 100, I_{\rm F} = 04$	4	-	19	-	pF
witching	g Characte	eristics						
t _{rr}	Reverse Re	ecovery Time	$\begin{split} I_{F} &= 1A, d_{IF}/dt = 100A/\mu s, V_{R} = 30V \\ I_{F} &= 4A, d_{IF}/dt = 100A/\mu s, V_{R} = 30V \\ I_{F} &= 4A, \\ d_{IF}/dt = 200A/\mu s, \end{split}$		-	17	20	ns
					-	19	22	ns
t _{rr}	Reverse Re	ecovery Time			-	17	-	ns
I _{RRM}	Maximum F	Reverse Recovery Current			-	2.6	-	Α
Q _{RR}	Reverse Re	ecovery Charge	V _R = 390V, T _C =	25 C	-	22	-	nC
t _{rr}	Reverse Re	ecovery Time	I _F = 4A,		-	77	-	ns
	Softness Fa	actor (t _b /t _a)	$d_{IF}/dt = 200A/\mu s_{H}$		-	4.2	-	
S			$V_{\rm R} = 390V,$ - 2		2.8	-	A	
S I _{RRM}	Maximum F	Reverse Recovery Current			-	2.0		
		Reverse Recovery Current ecovery Charge	T _C = 125°C		-	100	-	nC
I _{RRM} Q _{RR} t _{rr}	Reverse Re		T _C = 125°C I _F = 4A,		-	100 54	-	nC ns
I _{RRM} Q _{RR}	Reverse Re Reverse Re Softness Fa	ecovery Charge ecovery Time actor (t _b /t _a)	$T_{C} = 125^{\circ}C$ $I_{F} = 4A,$ $d_{IF}/dt = 400A/\mu s$		- - -	100 54 3.5	-	-
I _{RRM} Q _{RR} t _{rr}	Reverse Re Reverse Re Softness Fa Maximum F	ecovery Charge ecovery Time actor (t _b /t _a) Reverse Recovery Current	T _C = 125°C I _F = 4A, d _{IF} /dt = 400A/μs, V _R = 390V,		- - - -	100 54 3.5 4.3	- - - -	-
I _{RRM} Q _{RR} t _{rr} S I _{RRM} Q _{RR}	Reverse Re Reverse Re Softness Fa Maximum F Reverse Re	ecovery Charge ecovery Time actor (t _b /t _a) Reverse Recovery Current ecovery Charge	$T_{C} = 125^{\circ}C$ $I_{F} = 4A,$ $d_{IF}/dt = 400A/\mu s$		-	100 54 3.5 4.3 110	- - - -	ns A nC
I _{RRM} Q _{RR} t _{rr} S I _{RRM}	Reverse Re Reverse Re Softness Fa Maximum F Reverse Re	ecovery Charge ecovery Time actor (t _b /t _a) Reverse Recovery Current	T _C = 125°C I _F = 4A, d _{IF} /dt = 400A/μs, V _R = 390V,		- - - -	100 54 3.5 4.3	- - - - -	ns A
I _{RRM} Q _{RR} t _{rr} S I _{RRM} Q _{RR} dI _M /dt	Reverse Re Reverse Re Softness Fa Maximum F Reverse Re	ecovery Charge ecovery Time actor (t_b/t_a) Reverse Recovery Current ecovery Charge di/dt during t_b	T _C = 125°C I _F = 4A, d _{IF} /dt = 400A/μs, V _R = 390V,		- - - - -	100 54 3.5 4.3 110	- - - - -	ns A nC
I _{RRM} Q _{RR} t _{rr} S I _{RRM} Q _{RR} dI _M /dt	Reverse Re Reverse Re Softness Fa Maximum F Reverse Re Maximum c Characteri	ecovery Charge ecovery Time actor (t_b/t_a) Reverse Recovery Current ecovery Charge di/dt during t_b	T _C = 125°C I _F = 4A, d _{IF} /dt = 400A/μs, V _R = 390V,		-	100 54 3.5 4.3 110	- - - - 2.6	ns A nC
I _{RRM} Q _{RR} t _{rr} S I _{RRM} Q _{RR} dI _M /dt	Reverse Re Reverse Re Softness Fa Maximum F Reverse Re Maximum c Characteri Thermal Re	ecovery Charge ecovery Time actor (t _b /t _a) Reverse Recovery Current ecovery Charge li/dt during t _b	$T_{C} = 125^{\circ}C$ $I_{F} = 4A,$ $d_{IF}/dt = 400A/\mu s,$ $V_{R} = 390V,$ $T_{C} = 125^{\circ}C$		- - - -	100 54 3.5 4.3 110 500		ns A nC A/µs
$\begin{array}{c} I_{RRM} \\ Q_{RR} \\ t_{rr} \\ S \\ I_{RRM} \\ Q_{RR} \\ dI_M/dt \\ \end{array}$	Reverse Re Reverse Re Softness Fa Maximum F Reverse Re Maximum c Characteri Thermal Re Thermal Re	ecovery Charge ecovery Time actor (t _b /t _a) Reverse Recovery Current ecovery Charge li/dt during t _b stics esistance Junction to Case	$T_{C} = 125^{\circ}C$ $I_{F} = 4A,$ $d_{IF}/dt = 400A/\mu s,$ $V_{R} = 390V,$ $T_{C} = 125^{\circ}C$ TO-220			100 54 3.5 4.3 110 500	2.6	ns A nC A/µs °C/W

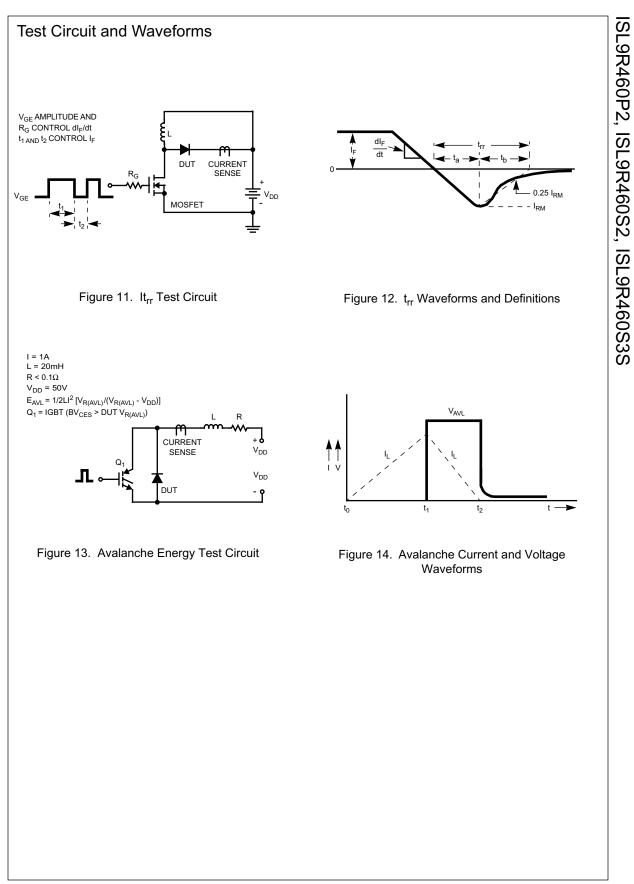


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ISL9R460P2, ISL9R460S2, ISL9R460S3S Rev. B



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